Unit: mm

TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel IGBT

# GT30J126

# High Power Switching Applications Fast Switching Applications

- Fourth-generation IGBT
- Enhancement mode type
- Fast switching (FS):

High speed:  $t_f = 0.05 \mu s$  (typ.)

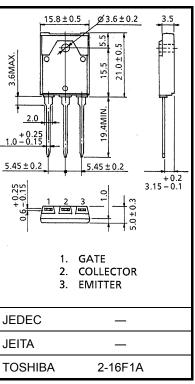
Low switching loss:  $E_{on} = 1.00 \text{ mJ (typ.)}$ 

 $: E_{off} = 0.80 \text{ mJ (typ.)}$ 

• Low saturation voltage: VCE (sat) = 1.95 V (typ.)

### **Absolute Maximum Ratings (Ta = 25°C)**

| Characteristics                         |      | Symbol           | Rating     | Unit |  |
|---|------|------------------|------------|------|--|
| Collector-emitter voltage               |      | V <sub>CES</sub> | 600        | V    |  |
| Gate-emitter voltage                    |      | V <sub>GES</sub> | ±20        | V    |  |
| Collector current                       | DC   | Ic               | 30         | А    |  |
|   | 1 ms | I <sub>CP</sub>  | 60         |      |  |
| Collector power dissipation (Tc = 25°C) |      | P <sub>C</sub>   | 90         | W    |  |
| Junction temperature                    |      | Tj               | 150        | °C   |  |
| Storage temperature range               |      | T <sub>stg</sub> | -55 to 150 | °C   |  |



Weight: 5.8 g (typ.)

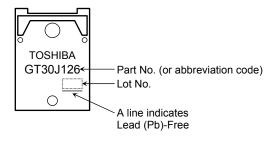
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

| Characteristics    | Symbol                | Max  | Unit |
|--------------------|-----------------------|------|------|
| Thermal resistance | R <sub>th (j-c)</sub> | 1.39 | °C/W |

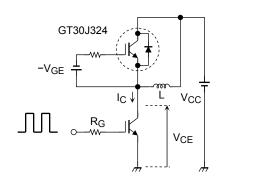
#### Marking

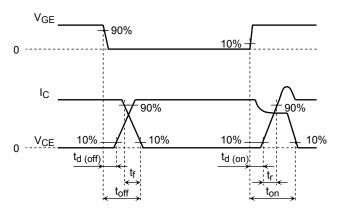


# **Electrical Characteristics (Ta = 25°C)**

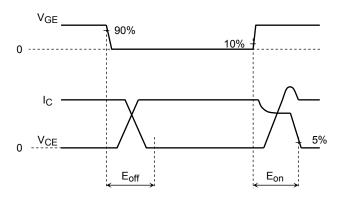
| Cha                                  | racteristics            | Symbol                | Test Condition  | Min | Тур. | Max  | Unit |
|--------------------------------------|-------------------------|-----------------------|---|-----|------|------|------|
| Gate leakage cu                      | ırrent                  | I <sub>GES</sub>      | V <sub>GE</sub> = ±20 V, V <sub>CE</sub> = 0  | _   | _    | ±500 | nA   |
| Collector cut-off current            |                         | I <sub>CES</sub>      | V <sub>CE</sub> = 600 V, V <sub>GE</sub> = 0  | _   | _    | 1.0  | mA   |
| Gate-emitter cut-off voltage         |                         | V <sub>GE</sub> (OFF) | I <sub>C</sub> = 3 mA, V <sub>CE</sub> = 5 V  | 3.5 | _    | 6.5  | V    |
| Collector-emitter saturation voltage |                         | V <sub>CE</sub> (sat) | I <sub>C</sub> = 30 A, V <sub>GE</sub> = 15 V   | _   | 1.95 | 2.45 | V    |
| Input capacitance                    |                         | C <sub>ies</sub>      | V <sub>CE</sub> = 10 V, V <sub>GE</sub> = 0, f = 1 MHz  | _   | 4650 | _    | pF   |
| Switching time                       | Turn-on delay time      | t <sub>d (on)</sub>   | Inductive Load $V_{CC} = 300 \text{ V, } I_{C} = 30 \text{ A}$ $V_{GG} = +15 \text{ V, } R_{G} = 24 \Omega$ (Note 1) (Note 2) | _   | 0.09 | _    | μs   |
|                                      | Rise time               | t <sub>r</sub>        |   | _   | 0.07 | _    |      |
|                                      | Turn-on time            | t <sub>on</sub>       |   | _   | 0.24 | _    |      |
|                                      | Turn-off delay time     | <sup>t</sup> d (off)  |   | _   | 0.30 | _    |      |
|                                      | Fall time               | t <sub>f</sub>        |   | _   | 0.05 | _    |      |
|                                      | Turn-off time           | t <sub>off</sub>      |   | _   | 0.43 | _    |      |
| Switching loss                       | Turn-on switching loss  | E <sub>on</sub>       |   | _   | 1.00 | _    | - mJ |
|                                      | Turn-off switching loss | E <sub>off</sub>      |   | _   | 0.80 |      |      |

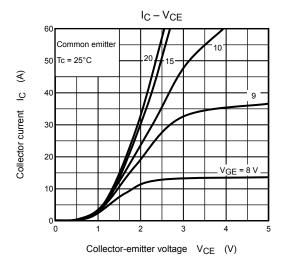
Note 1: Switching time measurement circuit and input/output waveforms

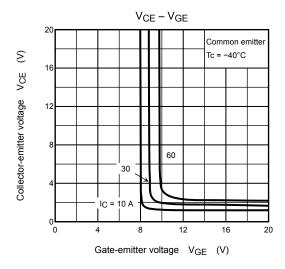


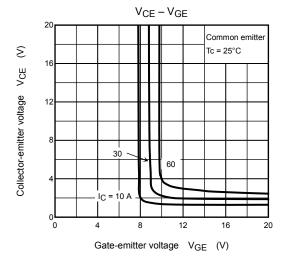


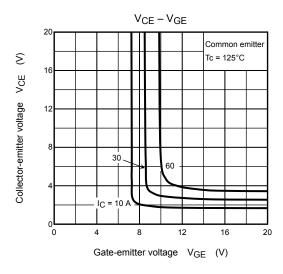
Note 2: Switching loss measurement waveforms

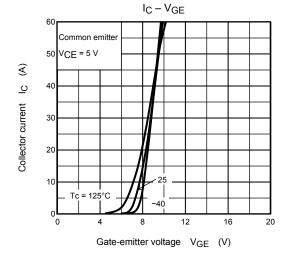


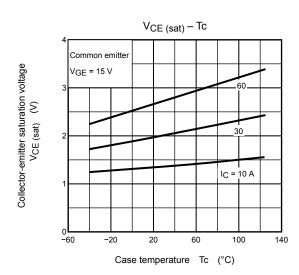




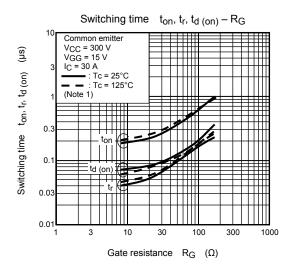


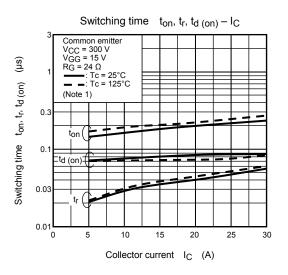


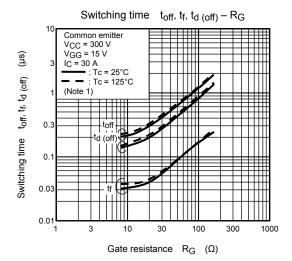


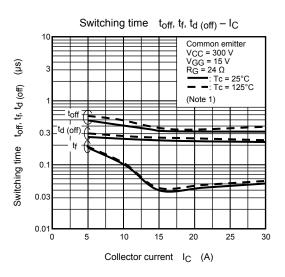


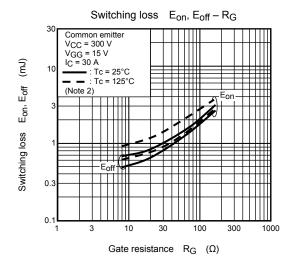
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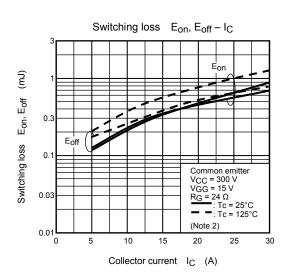


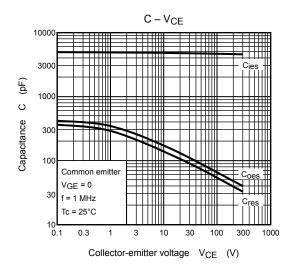


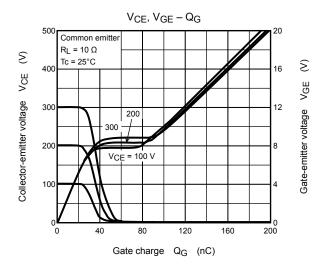


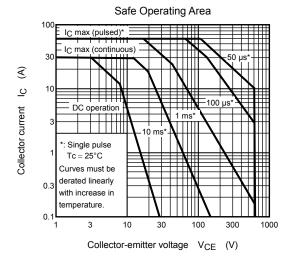


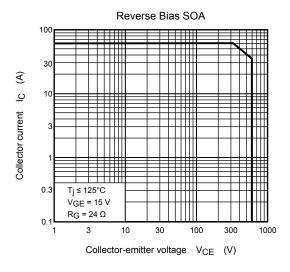


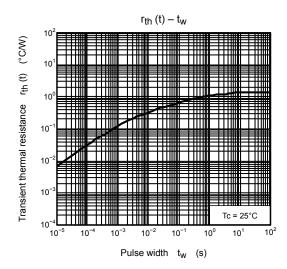












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